

# **A study for highly-reliable optical transceiver based on Si Photonics technology**

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Optical PHY Study Group

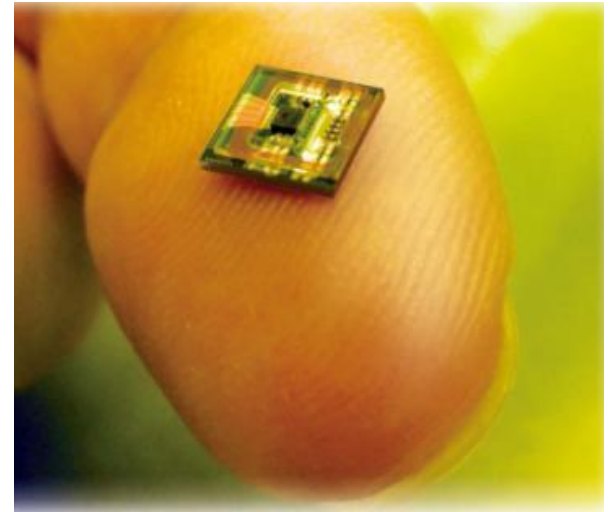
# Introduction

## Last Hawaii Meeting

I. Ogura and K. Kurata “Introduction of Si Photonics transceiver technology with High temperature operation capability and MMF transmission”

Data-based approach of Si Photonics for Automobile applications for High speed, High temperature and High reliability

- High speed: 25Gbps and higher
- High temperature:  
Quantum Dot (QD) Laser Source operates over 105°C
- Reliability:  
QD-LD lifetime expected over 20 years @105°C



## This Presentation

A study for highly-reliable optical transceiver based on Si Photonics

- Redundant laser light sources integrated in a transceiver chip employing a design for mission-critical HPC applications

# Discussion on reliability assessment for automobile applications

- September 2019 Indianapolis, IN;

  - “Open discussion on objectives”

  - ”Technical and economic feasibilities Requirements and methodology for assessment”

- November 2019 Waikoloa, HI;

  - “VCSEL reliability analysis for technical feasibility assessment”

→ 1-10 FIT for 15 years @temperature 105°C (125 °C)

## Challenging in Quality Control of optical modules

### Compare to Repeater in Submarine cable systems

22 FIT for 25 years @0-35 °C (<1 ship repair of 200 repeaters/system)

employing redundancy of active components: 4 LDs (Fujitsu.58 (07, 2007))

This talk: our package strategy for

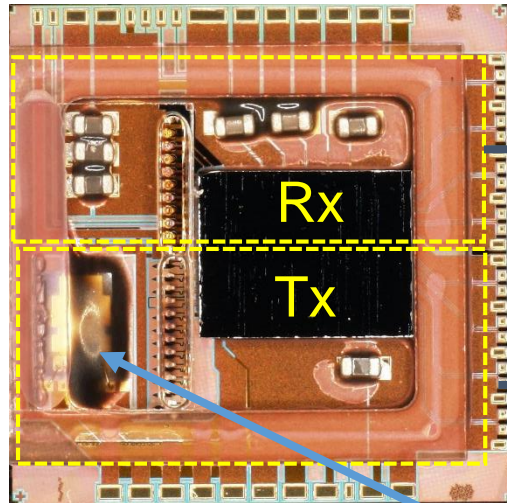
Mission-critical server and HPC:RAS(Reliability, Availability, Serviceability)

Example of Si Photonics transceiver with Quantum-Dot laser + Redundancy

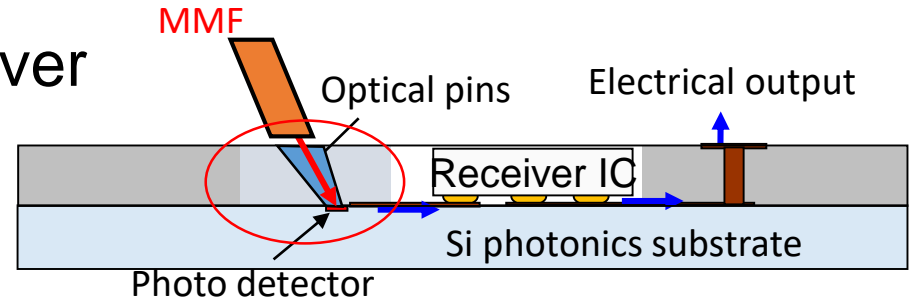
for feasibility and specification assessment

# Si photonics with QD-laser and MMF optics for short reach interconnects incl. automobile

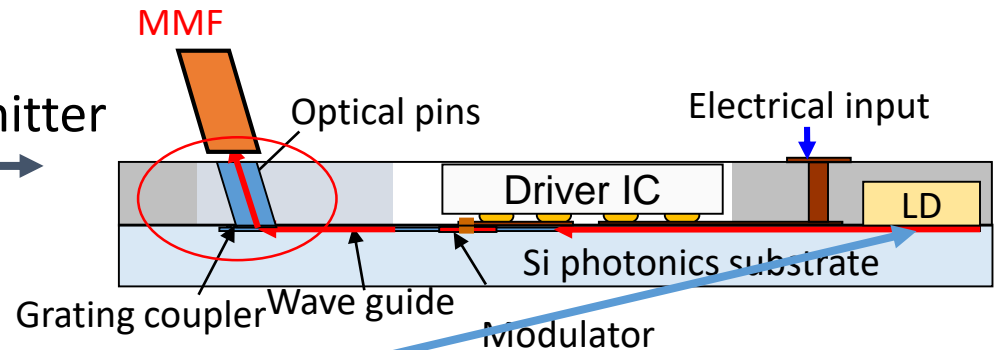
## Si photonics one-chip transceiver



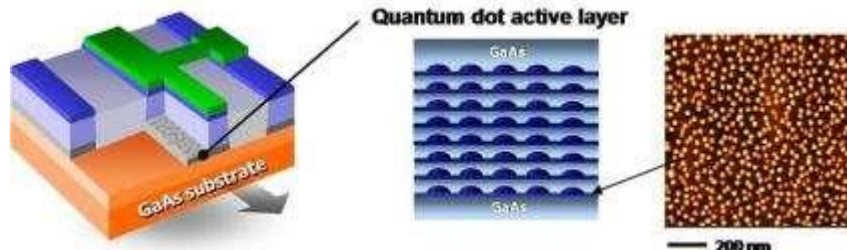
Receiver



Transmitter



## Quantum dot laser light source



# LD lifetime test results (tentative up to 105°C)

Acceleration test (Po=31mW)  
for QD laser Results in  
Ea=0.746eV

Arrhenius equation

$$\kappa = A * \text{EXP}(-E_a / (k_B * T))$$

where  $\kappa$  : rate constant

Ea: Activation energy 0.746eV

kB: Boltzmann Constant(=8.617\*E-5 eV/K)

T : Absolute temperature( in kelvins)

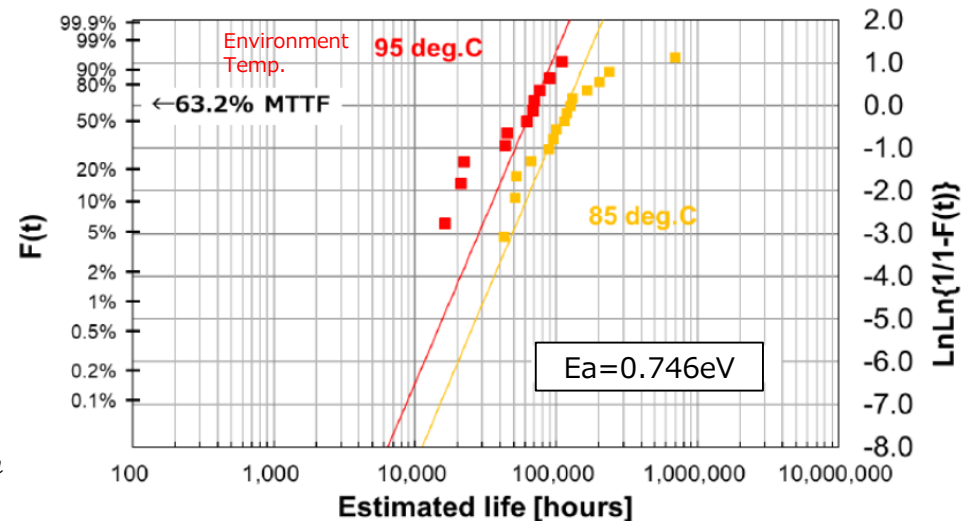
MTTF in actual use at Po=20mW  
for Ea=0.746eV  
Expected to be 20 years at 105°C

$$k = k_0 * \exp\{E_a / k_B * (1/T - 1/T_0)\} * (I/I_0)^{-n} * (P/P_0)^{-m}$$

assumed n=2 & m=1

Redundancy will give  
higher reliability and availability  
(continuous operation)

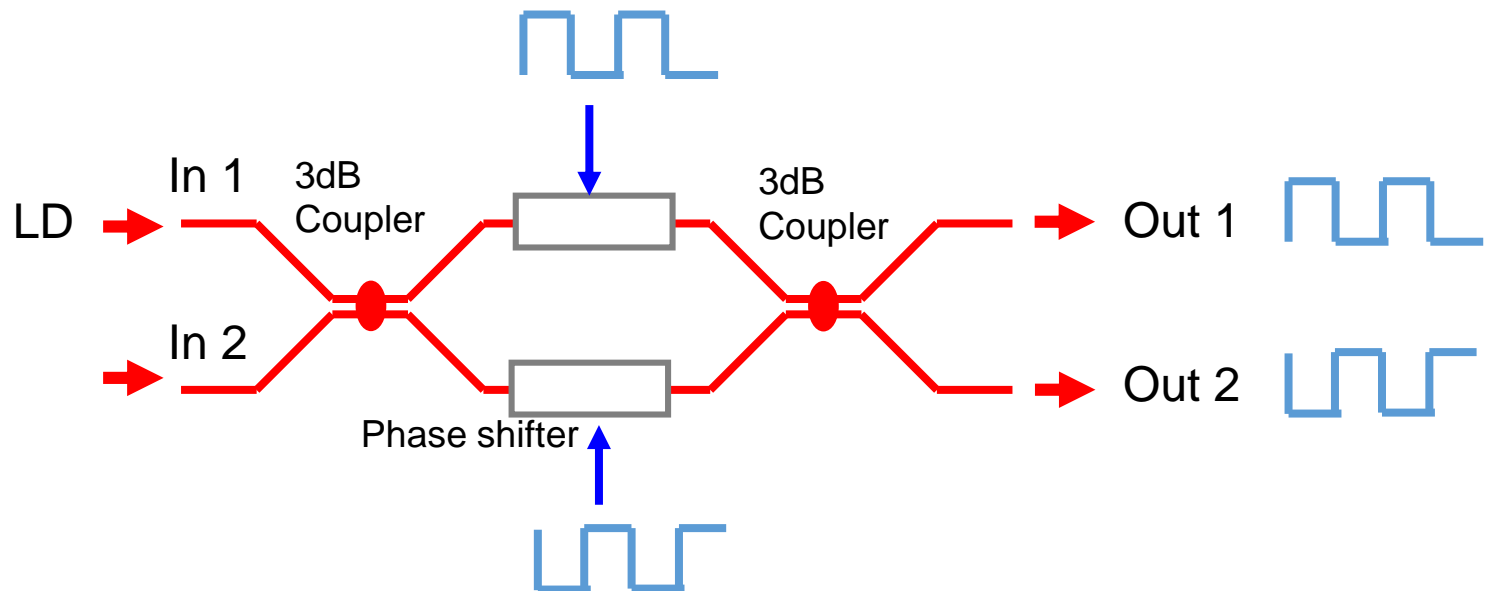
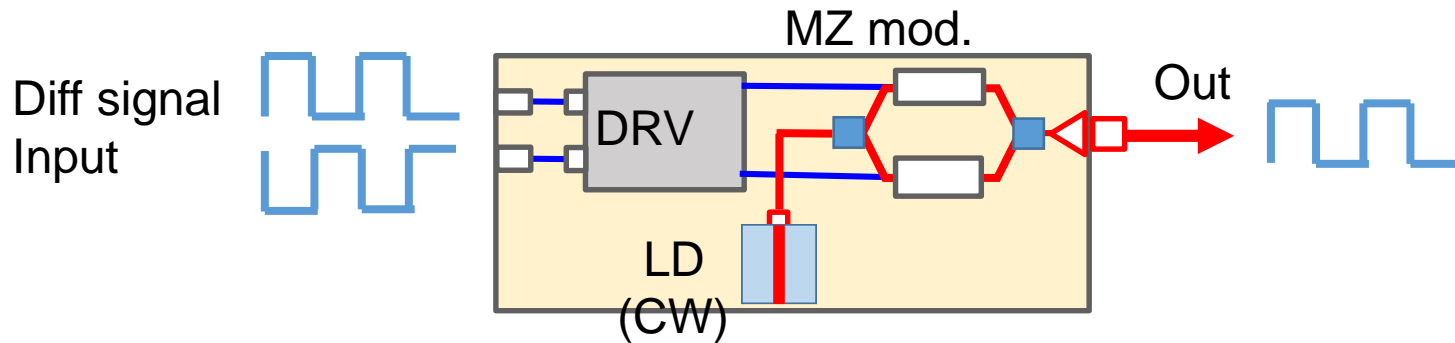
	85°C	95°C
MTTF (Cumulative failure rate, F(t)=63.2%)	134,470 [hours]	63,682 [hours]
Median life (Cumulative failure rate, F(t)=50%)	112,450 [hours]	50,470 [hours]



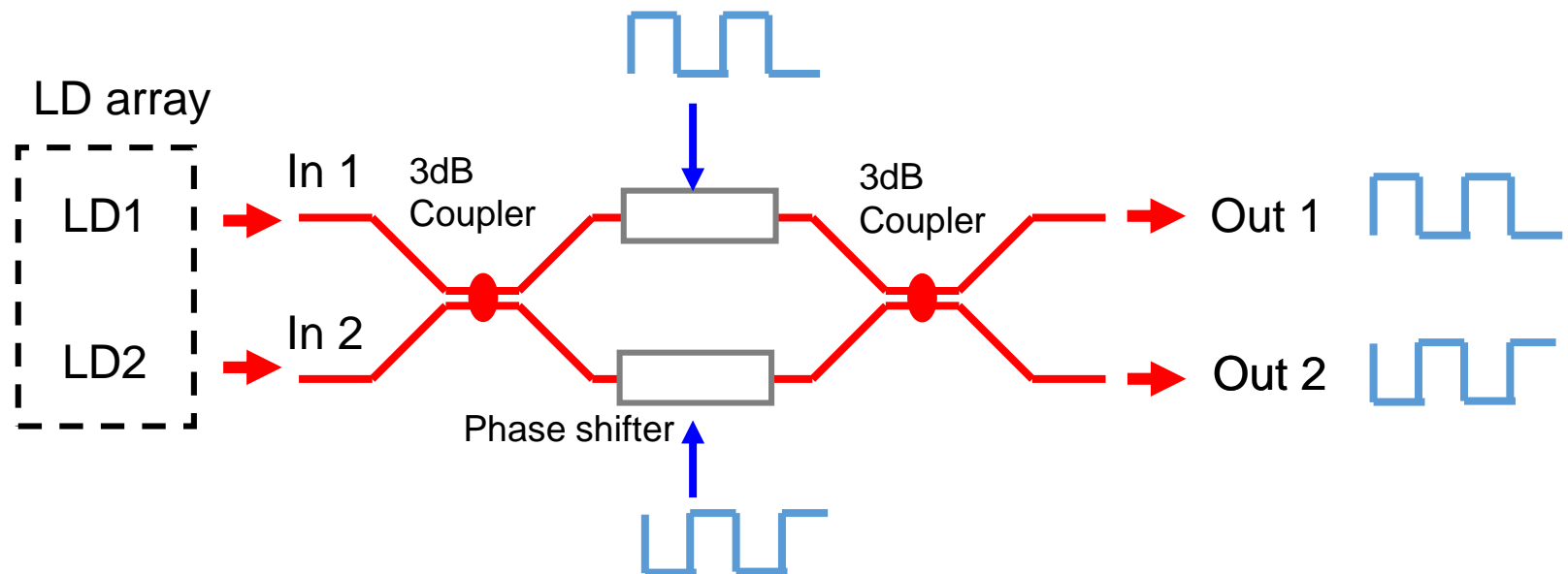
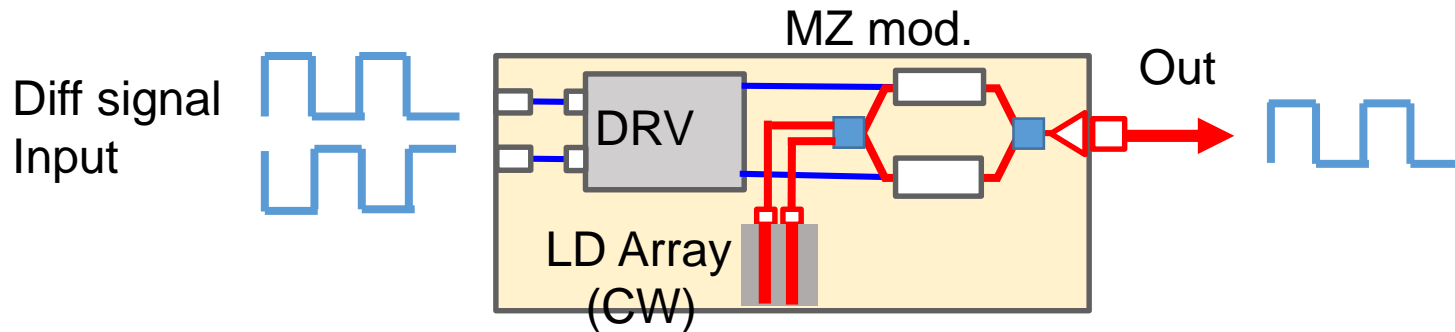
Actual use condition(20mW@100mA, TO CAN)

Environment Temp.	Junction Temp. Tj(°C)	MTTF of 4 Channels (years)
60°C	68.1	642
85°C	95.0	87.5
105°C	116.8	20.9

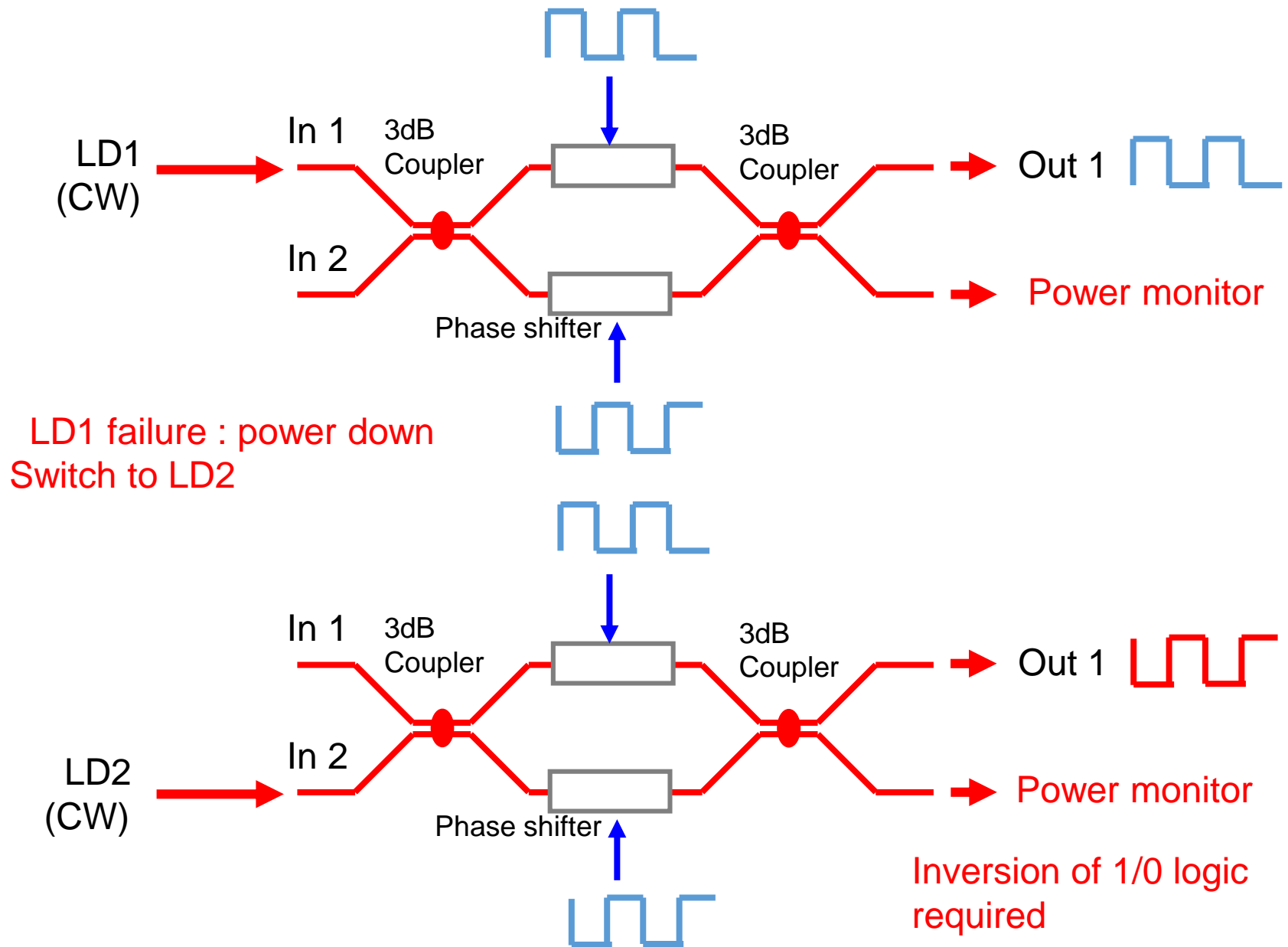
# Mach-Zehnder modulator integrated in Si Photonics chip



# Redundant light sources integrated in Si Photonics chip



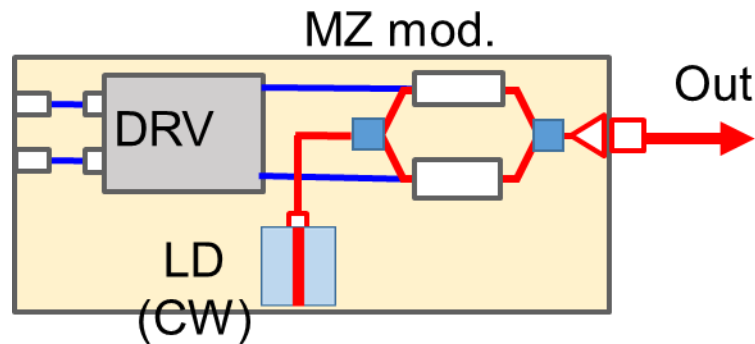
# Scenario of redundant operation



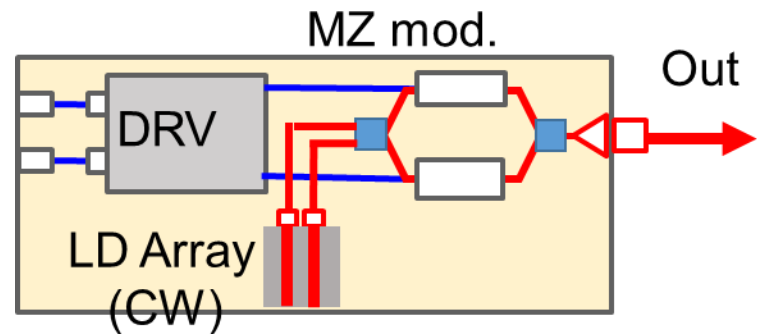


# Dual redundant for higher reliability and availability is feasible without major change in Si Photonics transceiver structure

Single LD



Dual redundant LD source



- Footprint of transceiver chip: same
- Size of LD chip: same
- MZ modulator structure: same except using MMI 2x2 couplers instead of 2x1
- Optical structure: same output coupling
- LD control: switch function added in LD driver,  
same power monitor used in the transmitter
- Logic : output logic is inverted by DC biasing to phase shifters

# Summary

A study for highly-reliable optical transceiver based on Si Photonics employing a design for mission-critical HPC applications

Dual redundant LD light source is feasible without major change in chip structure

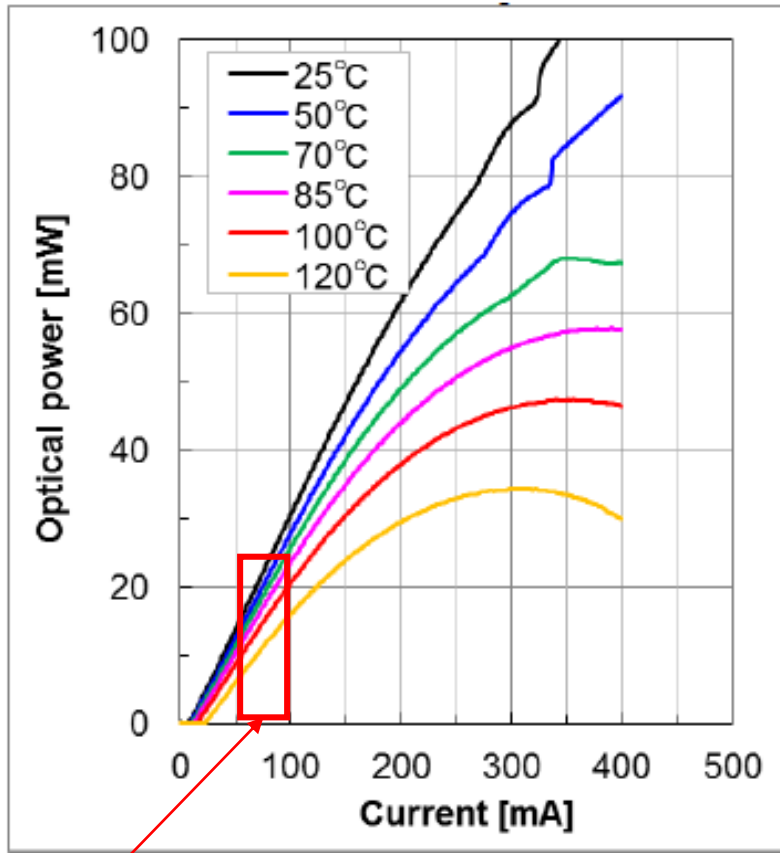
- High speed: 25Gbps and higher
- High temperature:  
Quantum Dot (QD) Laser Source operates over 105°C
- Reliability:  
QD-LD MTTF expected over 20 years @105°C  
Dual redundancy is feasible for higher reliability and availability

We would like to contribute to the specification assessment and appreciate your feedback

# Back up

# High temperature operation of Quantum Dot LD light source

(Temp. range limited by equipment)

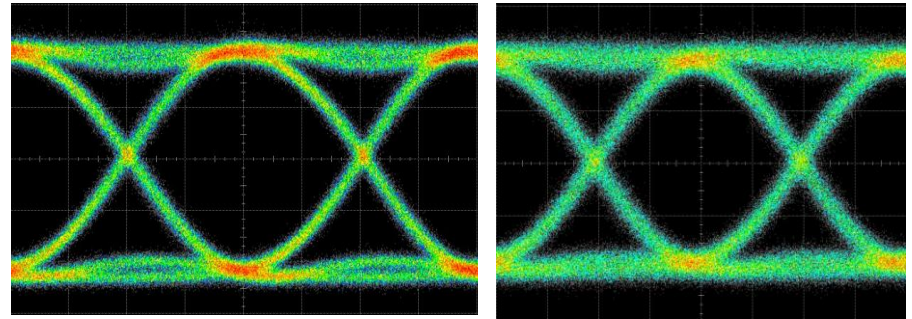


General Operation current

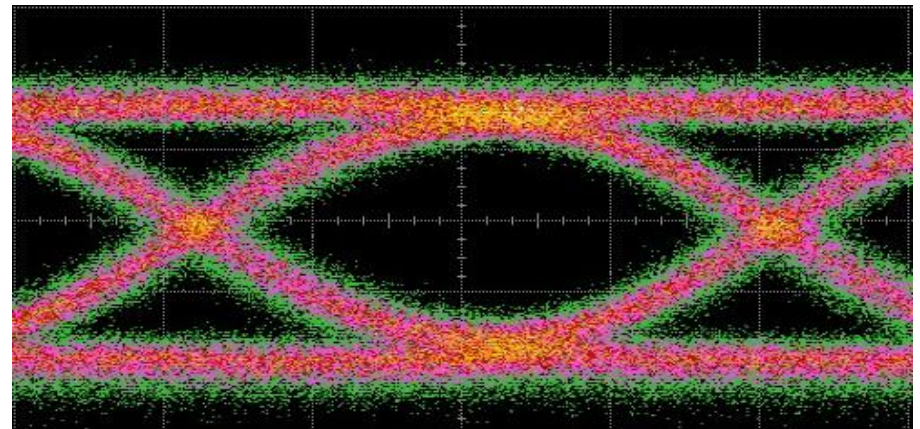
25Gbs Tx waveform

-5°C

85°C

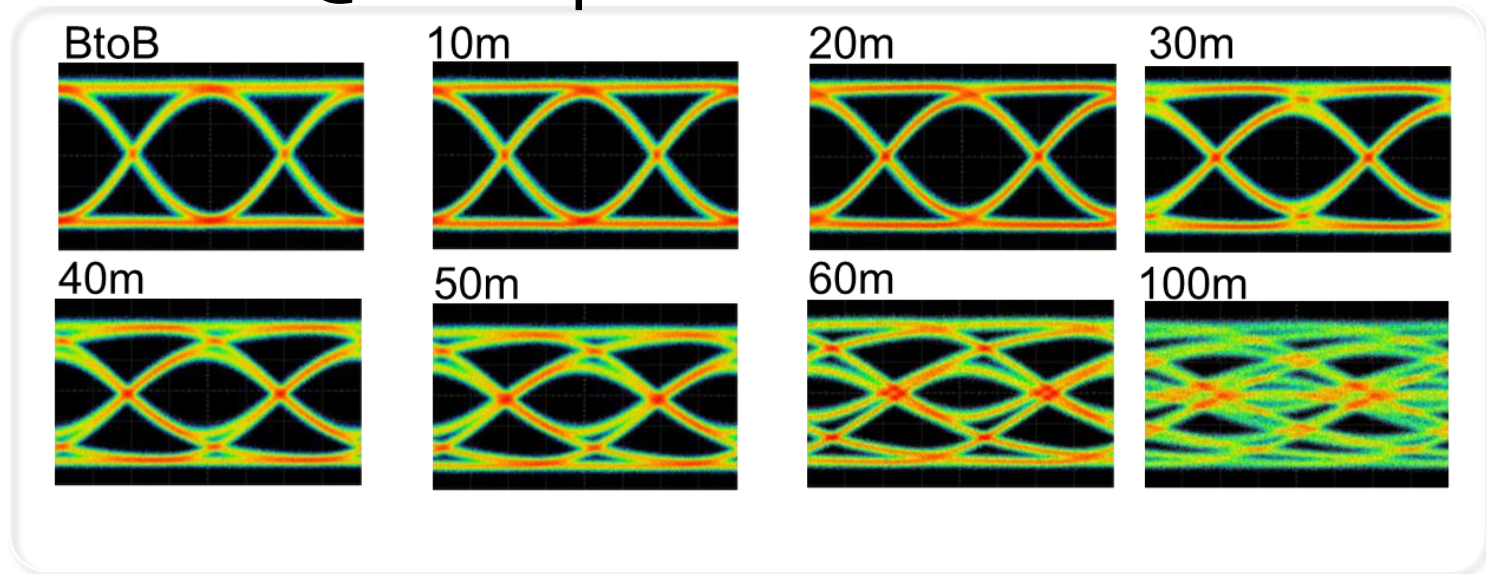


105°C (W/O LD bias control)

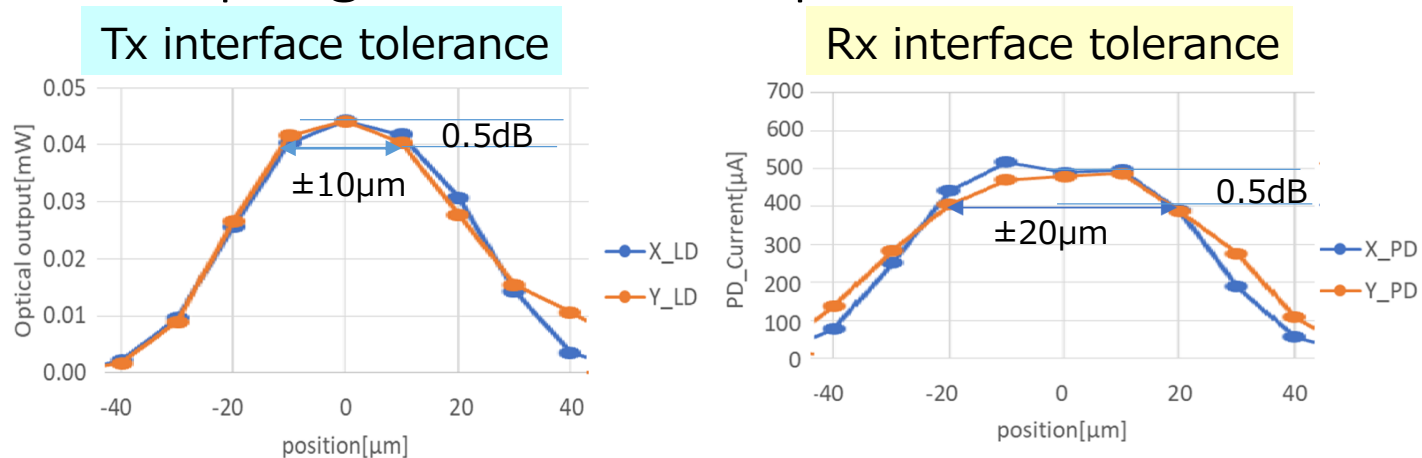


# MMF Transmission data for OM3

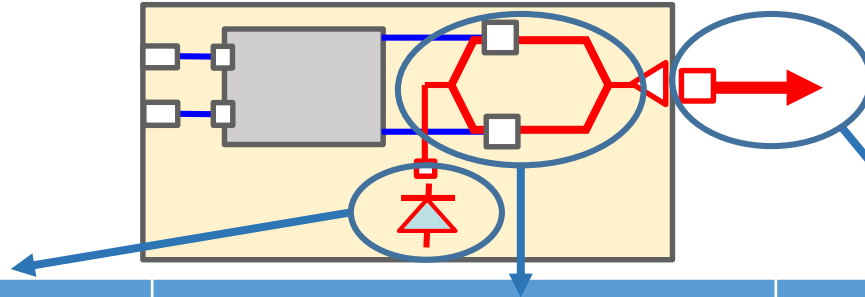
## OM3 >40m@25Gbps



Optical coupling tolerance >10 $\mu$ m for MMF



# Features for automobile applications



Quantum dot laser	Si photonics platform	MMF transmission
High temperature operation	Temperature independent modulator  High speed operation  High productivity (Low cost/High volume)	Large optical coupling tolerance (>10um)  MMF (OM3) for automobile reach (40m)



- Operation temperature up to 105 °C
- Operation up to 25Gbps (50G-NRZ in future)
- Commercial MMF(OM3) available for 40m reach